Power MOSFET 40 V, 1.3 mΩ, 235 A, Single N–Channel

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS5C426NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant



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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	1.3 mΩ @ 10 V	235 A

D (5,6) **Ç**

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted) Parameter Symbol Value Unit Drain-to-Source Voltage VDSS 40 V V_{GS} ±20 v Gate-to-Source Voltage I_{D} Continuous Drain $T_{\rm C} = 25^{\circ}{\rm C}$ 235 A Current R_{0JC} $T_C = 100^{\circ}C$ 166 (Notes 1, 3) Steady State Power Dissipation P_D W $T_C = 25^{\circ}C$ 128 $R_{\theta JC}$ (Note 1) $T_{\rm C} = 100^{\circ}{\rm C}$ 64 Continuous Drain $T_A = 25^{\circ}C$ 41 A I_D Current $R_{\theta JA}$ (Notes 1, 2, 3) 29 $T_A = 100^{\circ}C$ Steady State Power Dissipation $T_{\Delta} = 25^{\circ}C$ PD 3.8 W R_{θJA} (Notes 1 & 2) 1.9 $T_A = 100^{\circ}C$ **Pulsed Drain Current** $T_A = 25^{\circ}C$, $t_p = 10 \ \mu s$ 900 I_{DM} A °C **Operating Junction and Storage Temperature** T_J, T_{stq} -55 to + 175 Source Current (Body Diode) ls 122 А E_{AS} Single Pulse Drain-to-Source Avalanche 739 mJ Energy $(I_{L(pk)} = 19 \text{ A})$ Lead Temperature for Soldering Purposes ΤL 260 °C (1/8'' from case for 10 s)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

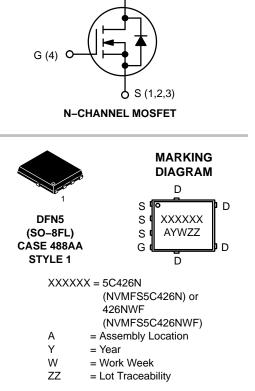
THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{ extsf{ heta}JC}$	1.2	°C/W
Junction-to-Ambient - Steady State (Note 2)	R_{\thetaJA}	39	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ORDERING INFORMATION

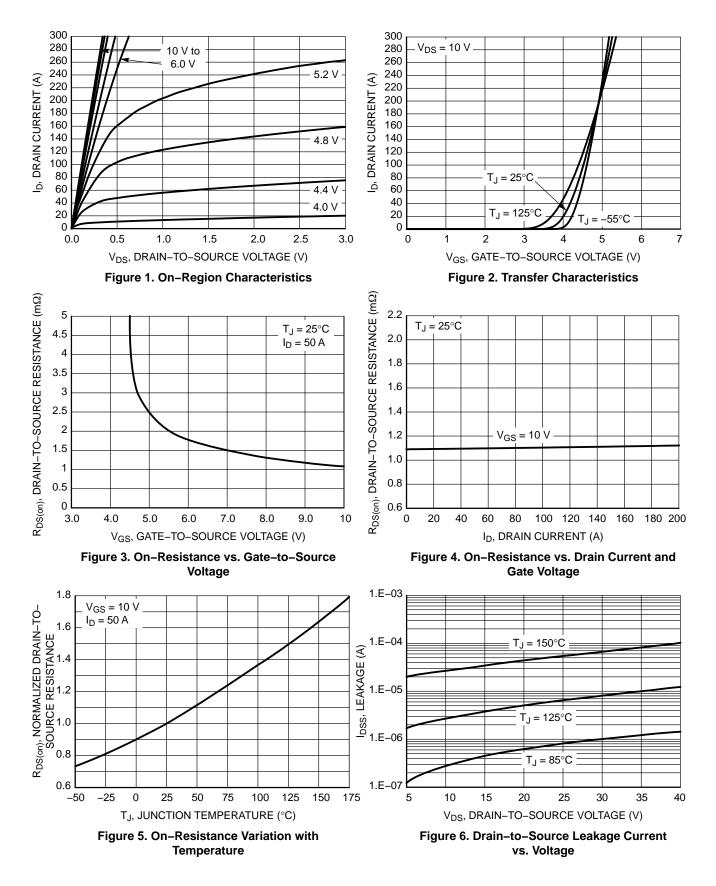
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

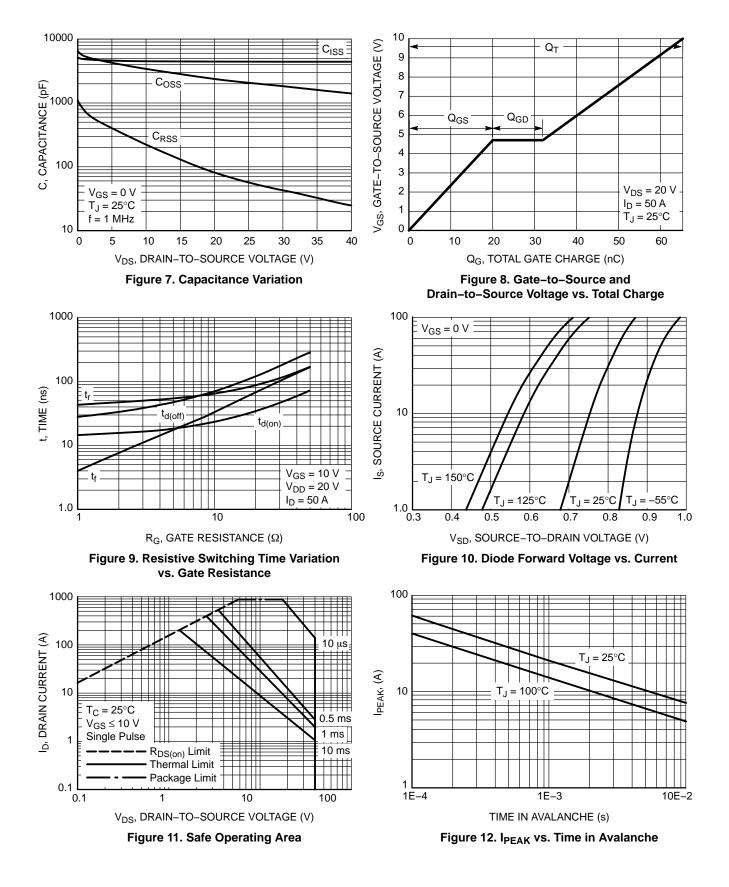
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D = 250 \mu A$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				9.6		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	1/20 - 40 1/2	$T_J = 25^{\circ}C$			10	μΑ
			T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 250 μA	2.5		3.5	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-8.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 50 A		1.1	1.3	mΩ
Forward Transconductance	9FS	V _{DS} =15 V, I _E	₀ = 50 A		145		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}, V_{DS} = 25 \text{ V}$ $V_{GS} = 10 \text{ V}, V_{DS} = 20 \text{ V}; \text{ I}_{D} = 50 \text{ A}$			4300		pF
Output Capacitance	C _{OSS}				2100		
Reverse Transfer Capacitance	C _{RSS}				59		
Total Gate Charge	Q _{G(TOT)}				65		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			13		nC
Gate-to-Source Charge	Q _{GS}				20		
Gate-to-Drain Charge	Q _{GD}				12		
Plateau Voltage	V _{GP}				4.7		V
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t _{d(ON)}				15		
Rise Time	t _r	V _{GS} = 10 V, V _D	s = 20 V,		47		
Turn–Off Delay Time	t _{d(OFF)}	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \; V, \; V_{DS} = 20 \; V, \\ I_{D} = 50 \; A, \; R_{G} = 2.5 \; \Omega \end{array}$			36		ns
Fall Time	t _f				9.0		
DRAIN-SOURCE DIODE CHARACTERIS	TICS				•		•
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.82	1.2	
		T _J = 125°C		0.68		V	
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 50 A			63		ns
Charge Time	ta				34		
Discharge Time	t _b				29		
Reverse Recovery Charge	Q _{RR}				92		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width $\leq 300 \,\mu$ s, duty cycle $\leq 2\%$. 5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

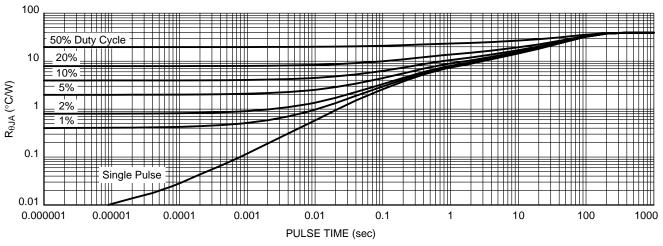


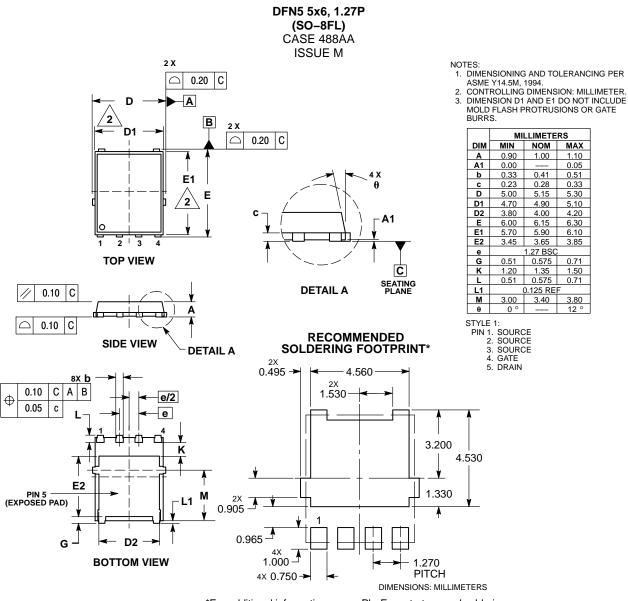
Figure 13. Thermal Characteristics

DEVICE ORDERING	INFORMATION
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Device	Marking	Package	Shipping [†]
NVMFS5C426NT1G	5C426N	DFN5 (Pb–Free)	1500 / Tape & Reel
NVMFS5C426NWFT1G	426NWF	DFN5 (Pb–Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS5C426NT3G	5C426N	DFN5 (Pb–Free)	5000 / Tape & Reel
NVMFS5C426NWFT3G	426NWF	DFN5 (Pb–Free, Wettable Flanks)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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PUBLICATION ORDERING INFORMATION

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